

Search Notes



Application/Control No.

10/650,458

Examiner

Hiep T. Nguyen

Applicant(s)/Patent under Reexamination

ROEHR ET AL.

Art Unit

2187

SEARCHED

| Class | Subclass | Date | Examiner |
|---|----------|---------|----------|
| 711 | 103 | 9/18/05 | H2 |
| | 118 | ↓ | ↓ |
| (Tesp + search - only - see EAST print out) | | | |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)

| | DATE | EXMR |
|---|---------|------|
| EAST search list is attached. | 9/18/05 | H2 |
| NPL search. Using terms similar to EAST search. | ↓ | ↓ |
| Inventor ship search | ↓ | ↓ |
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